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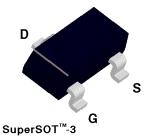
# NDS336P P-Channel Logic Level Enhancement Mode Field Effect Transistor

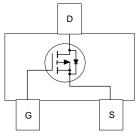
#### **General Description**

SuperSOT<sup>™</sup>-3 P-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications such as notebook computer power management, portable electronics, and other battery powered circuits where fast high-side switching, and low in-line power loss are needed in a very small outline surface mount package.

### Features

- -1.2 A, -20 V,  $R_{DS(ON)} = 0.27 \ \Omega \ @ V_{GS} = -2.7 \ V$  $R_{DS(ON)} = 0.2 \ \Omega \ @ V_{GS} = -4.5 \ V.$
- Very low level gate drive requirements allowing direct operation in 3V circuits. V<sub>GS(th</sub>) < 1.0V.</li>
- Proprietary package design using copper lead frame for superior thermal and electrical capabilities.
- High density cell design for extremely low R<sub>DS(ON)</sub>.
- Exceptional on-resistance and maximum DC current capability.
- Compact industry standard SOT-23 surface Mount package.



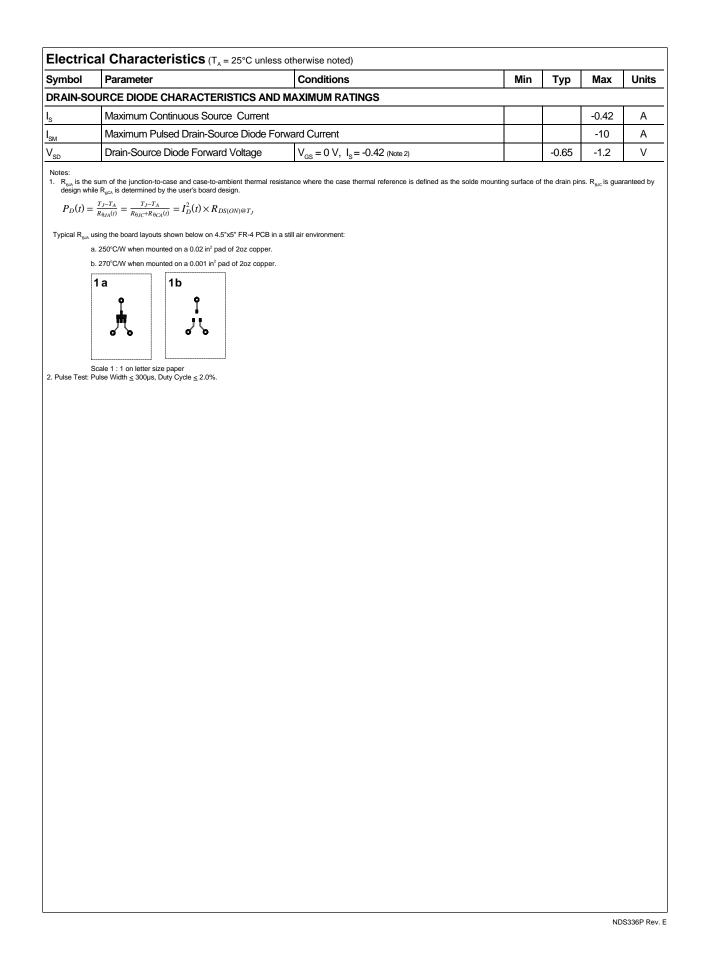


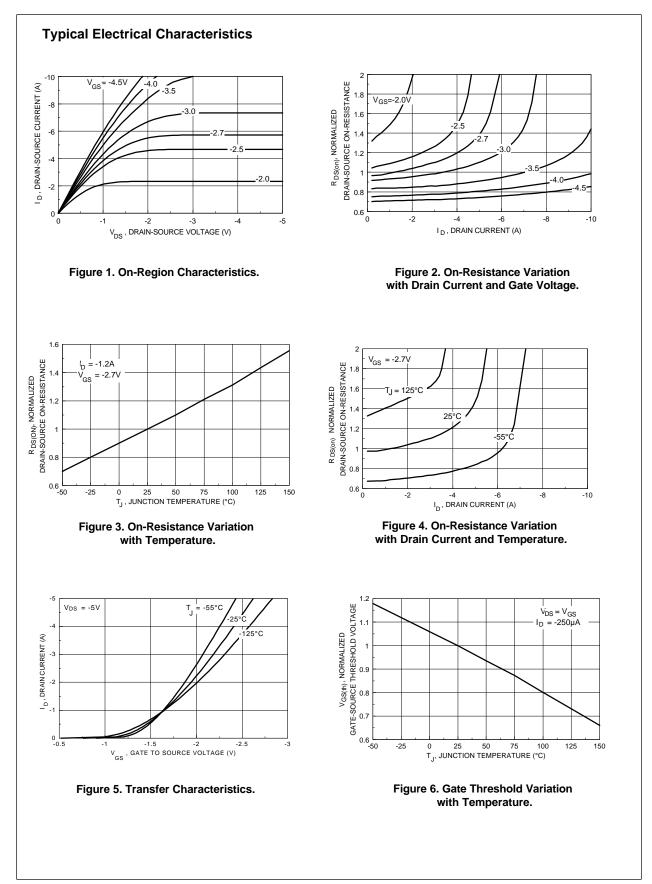
#### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		NDS336P	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
$V_{GSS}$	Gate-Source Voltage - Continuous		±8	V
l <sub>D</sub>	Maximum Drain Current - Continuous	(Note 1a)	-1.2	A
	- Pulsed		-10	
P <sub>D</sub>	Maximum Power Dissipation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to 150	°C
THERMA	L CHARACTERISTICS			
R <sub>eja</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

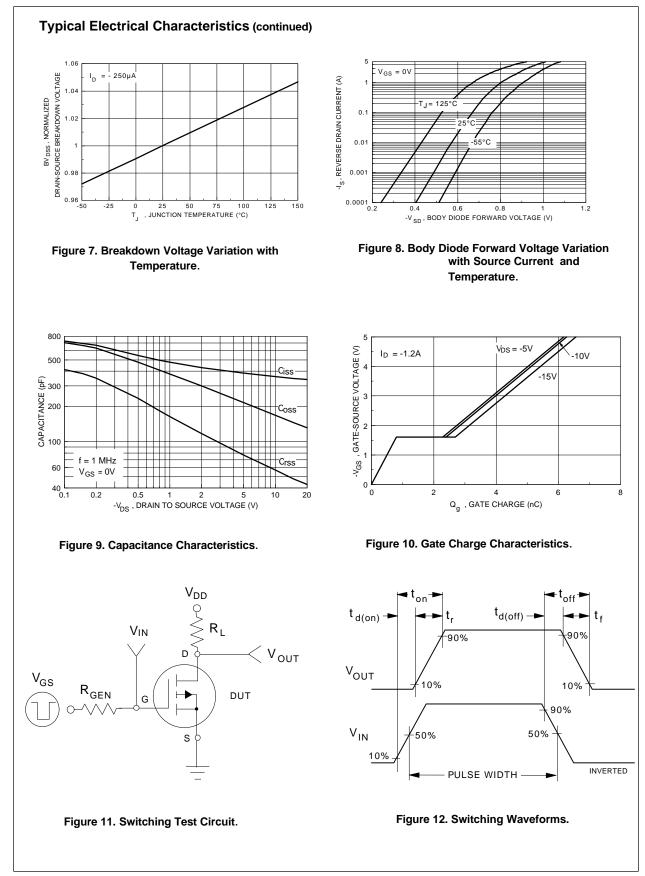
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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>p</sub> = -250 μA		-20			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$				-1	μA
			T_ =55°C			-10	μA
I <sub>GSS</sub>	Gate - Body Leakage Current	$V_{GS} = 8 V, V_{DS} = 0 V$				100	nA
I <sub>GSS</sub>	Gate - Body Leakage Current	$V_{GS} = -8 V, V_{DS} = 0 V$				-100	nA
ON CHAR	ACTERISTICS (Note 2)				•	•	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = -250 \mu {\rm A}$		-0.5	-0.78	-1	V
			T <sub>J</sub> =125°C	-0.3	-0.58	-0.8	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -2.7 \text{ V}, I_D = -1.2 \text{ A}$			0.22	0.27	Ω
			T <sub>J</sub> =125°C		0.34	0.49	1
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -1.3 \text{ A}$			0.16	0.2	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -2.7 \text{ V}, V_{DS} = -5 \text{ V}$		-2			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 V, I_{D} = -1.2 A$			-3		S
DYNAMIC	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 V, V_{GS} = 0 V,$			360		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz			170		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				60		pF
SWITCHIN	IG CHARACTERISTICS (Note 2)						
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DD} = -5 V, I_{D} = -1 A,$			8	15	ns
t,	Turn - On Rise Time	$V_{\rm GS} = -4.5 \text{ V}, \ \text{R}_{\rm GEN} = 6 \ \Omega$			29	50	ns
t <sub>D(off)</sub>	Turn - Off Delay Time				33	60	ns
t <sub>r</sub>	Turn - Off Fall Time				23	45	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1.2 \text{ A},$ $V_{GS} = -4.5 \text{ V}$			5.7	8.5	nC
Q <sub>gs</sub>	Gate-Source Charge				0.7		nC
$Q_{gd}$	Gate-Drain Charge				1.8		nC

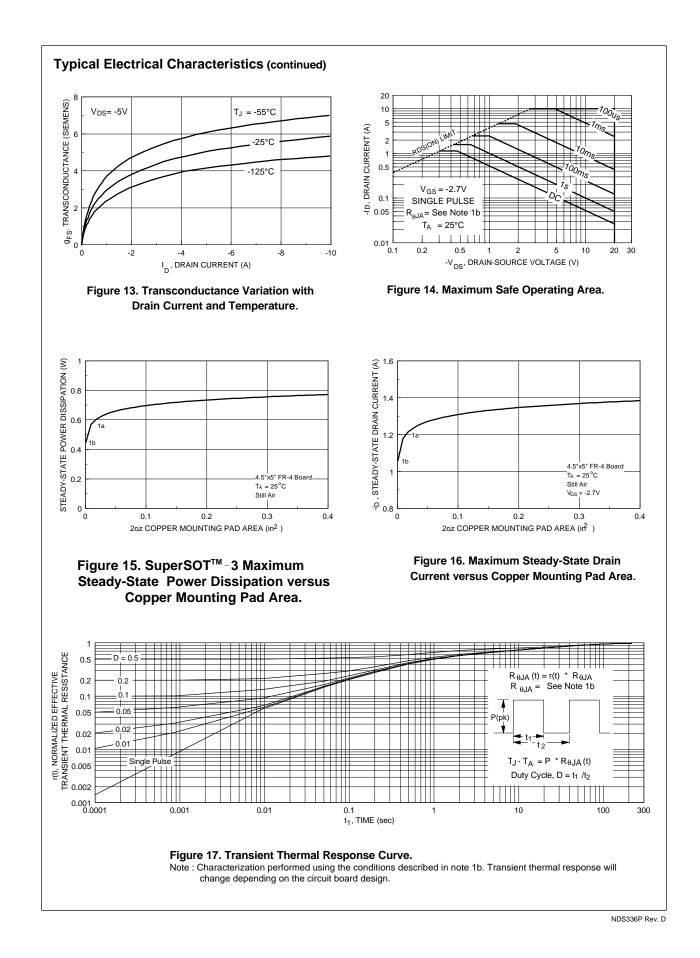




NDS336P Rev. D



NDS336P Rev. D



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